Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ier
09/920,853	LEE, JAE-HYUK	
Examiner	Art Unit	
Pankaj Kumar	2611	

Pankaj Kumar

SEARCHED					
Class	Subclass	Date	Examiner		
375	229, 230, 231, 232, 233, 295	4/16/2006	PK		
375	296, 297	4/16/2006	PK		
324	620, 612	4/16/2006	PK		
324	600,	4/16/2006	PK		
370	241, 249	4/16/2006	PK		
455	296	4/16/2006	PK		
708	300, 322	4/16/2006	PK		
708	323	4/16/2006	PK		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		4/16/2006	PK
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